

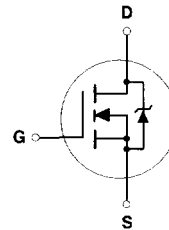
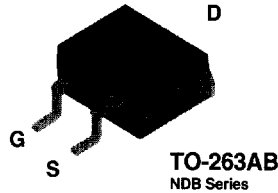
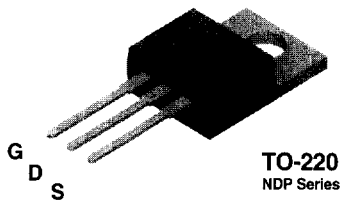
NDP7051 / NDB7051 N-Channel Enhancement Mode Field Effect Transistor

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulses in the avalanche and commutation modes. These devices are particularly suited for low voltage applications such as automotive, DC/DC converters, PWM motor controls, and other battery powered circuits where fast switching, low in-line power loss, and resistance to transients are needed.

Features

- 70A, 50V. $R_{DS(ON)} = 0.013\Omega @ V_{GS}=10V$.
- Critical DC electrical parameters specified at elevated temperature.
- Rugged internal source-drain diode can eliminate the need for an external Zener diode transient suppressor.
- 175°C maximum junction temperature rating.
- High density cell design for extremely low $R_{DS(ON)}$.
- TO-220 and TO-263 (D²PAK) package for both through hole and surface mount applications.



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter	NDP7051	NDB7051	Units
V _{DSS}	Drain-Source Voltage		50	V
V _{DGR}	Drain-Gate Voltage (R _{GS} ≤ 1 MΩ)		50	V
V _{GSS}	Gate-Source Voltage - Continuous - Nonrepetitive (t _p < 50 μs)		± 20	V
			± 40	
I _D	Drain Current - Continuous - Pulsed		70	A
			210	
P _D	Maximum Power Dissipation @ T _C = 25°C Derate above 25°C		130	W
			0.87	
T _J , T _{STG}	Operating and Storage Temperature Range		-65 to 175	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		275	°C

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
W_{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 25\text{ V}$, $I_D = 70\text{ A}$			500	mJ
I_{AR}	Maximum Drain-Source Avalanche Current				70	A

OFF CHARACTERISTICS

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}$, $I_D = 250\text{ }\mu\text{A}$	50			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 40\text{ V}$, $V_{GS} = 0\text{ V}$			10	μA
		$T_J = 125^\circ\text{C}$			1	mA
I_{GSSF}	Gate - Body Leakage, Forward	$V_{GS} = 20\text{ V}$, $V_{DS} = 0\text{ V}$			100	nA
I_{GSSR}	Gate - Body Leakage, Reverse	$V_{GS} = -20\text{ V}$, $V_{DS} = 0\text{ V}$			-100	nA

ON CHARACTERISTICS (Note 1)

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$	2	2.9	4	V
		$T_J = 125^\circ\text{C}$	1.4	2.2	3.6	
$R_{D(S(on)N)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}$, $I_D = 35\text{ A}$		0.011	0.013	Ω
		$T_J = 125^\circ\text{C}$		0.018	0.023	
$I_{D(on)}$	On-State Drain Current	$V_{GS} = 10\text{ V}$, $V_{DS} = 10\text{ V}$	60			A
g_{FS}	Forward Transconductance	$V_{DS} = 10\text{ V}$, $I_D = 35\text{ A}$		30		S

DYNAMIC CHARACTERISTICS

C_{GS}	Input Capacitance	$V_{DS} = 25\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1.0\text{ MHz}$		1930		pF
C_{OSS}	Output Capacitance			870		pF
C_{RSS}	Reverse Transfer Capacitance			310		pF

SWITCHING CHARACTERISTICS (Note 1)

$t_{D(on)}$	Turn - On Delay Time	$V_{DD} = 25\text{ V}$, $I_D = 70\text{ A}$, $V_{GS} = 10\text{ V}$, $R_{GEN} = 5\text{ }\Omega$		13	30	nS
t_r	Turn - On Rise Time			98	200	nS
$t_{D(off)}$	Turn - Off Delay Time			36	80	nS
t_f	Turn - Off Fall Time			65	150	nS
Q_g	Total Gate Charge	$V_{DS} = 48\text{ V}$, $I_D = 70\text{ A}$, $V_{GS} = 10\text{ V}$		67	100	nC
Q_{GS}	Gate-Source Charge			11		nC
Q_{GD}	Gate-Drain Charge			38		nC

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units	
DRAIN-SOURCE DIODE CHARACTERISTICS							
I_S	Maximum Continuous Drain-Source Diode Forward Current				70	A	
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current				210	A	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 35\text{ A}$ (Note 1)			0.9	1.3	V
					0.8	1.2	
t_r	Reverse Recovery Time	$V_{GS} = 0\text{ V}, I_F = 70\text{ A}, dI_F/dt = 100\text{ A}/\mu\text{s}$	40	105	150	ns	
I_r	Reverse Recovery Current		2	4.5	10	A	
THERMAL CHARACTERISTICS							
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case				1.15	$^\circ\text{C}/\text{W}$	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient				62.5	$^\circ\text{C}/\text{W}$	

Note:

1. Pulse Test: Pulse Width $\leq 300\ \mu\text{s}$, Duty Cycle $\leq 2.0\%$.

Typical Electrical Characteristics

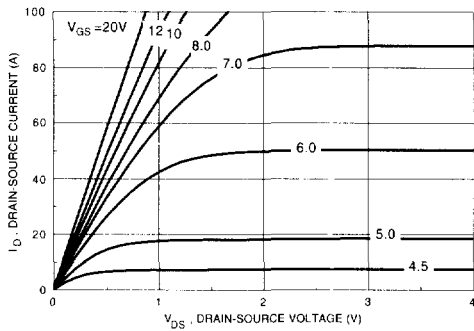


Figure 1. On-Region Characteristics.

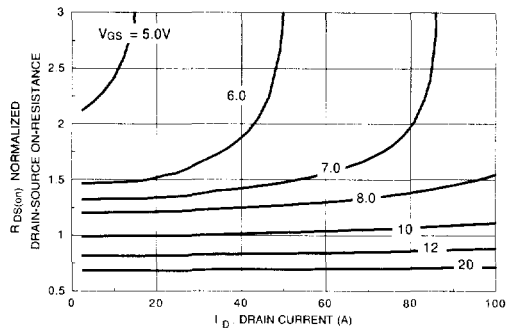


Figure 2. On-Resistance Variation with Gate Voltage and Drain Current.

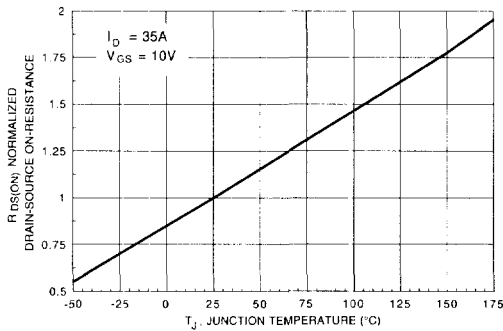


Figure 3. On-Resistance Variation with Temperature.

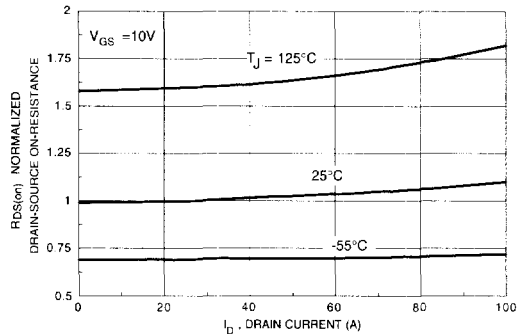


Figure 4. On-Resistance Variation with Drain Current and Temperature.

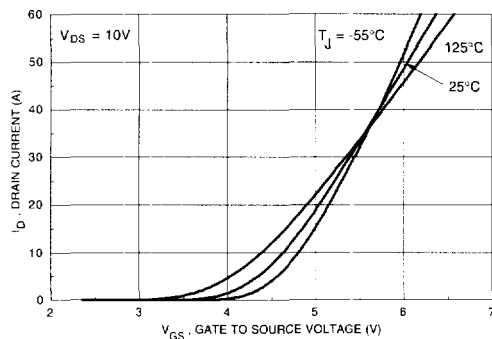


Figure 5. Transfer Characteristics.

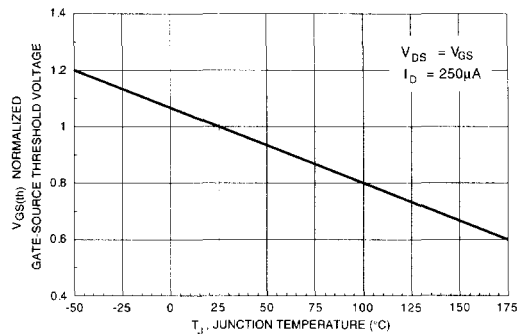


Figure 6. Gate Threshold Variation with Temperature.

Typical Electrical Characteristics (continued)

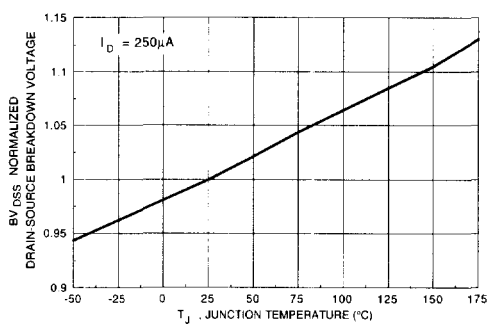


Figure 7. Breakdown Voltage Variation with Temperature.

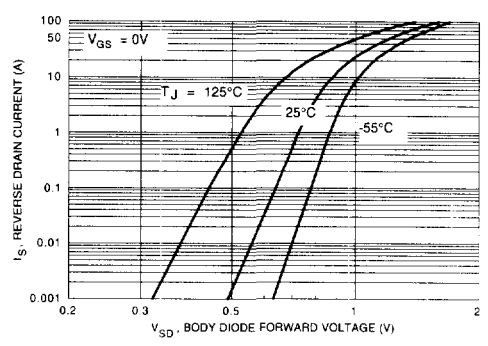


Figure 8. Body Diode Forward Voltage Variation with Current and Temperature.

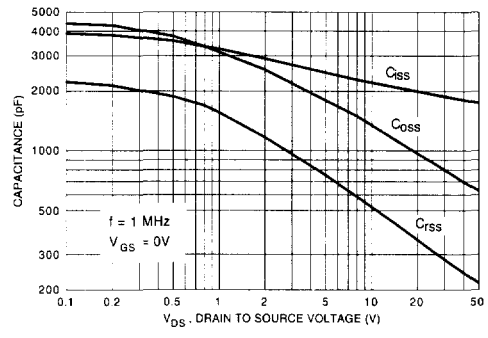


Figure 9. Capacitance Characteristics.

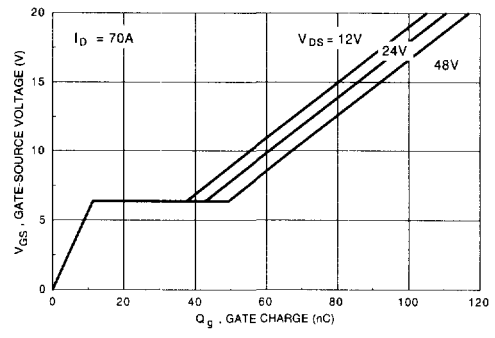


Figure 10. Gate Charge Characteristics.

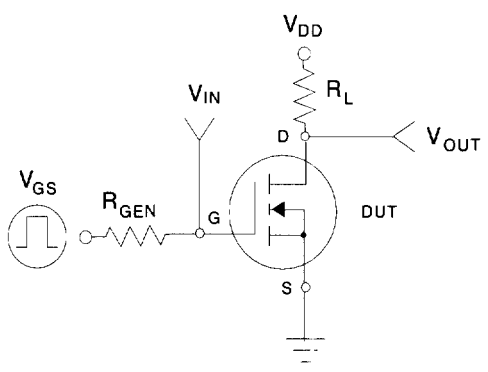


Figure 11. Switching Test Circuit.

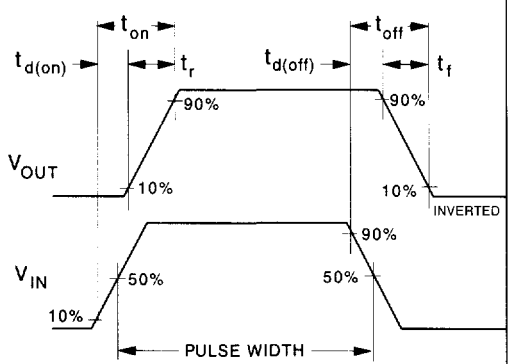


Figure 12. Switching Waveforms.

Typical Electrical Characteristics (continued)

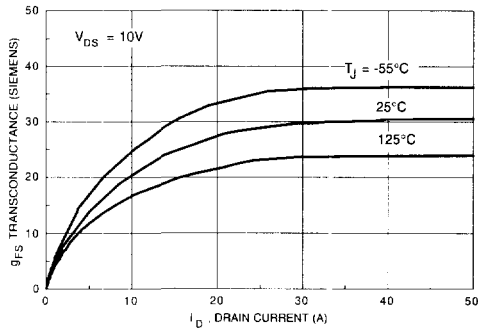


Figure 13. Transconductance Variation with Drain Current and Temperature.

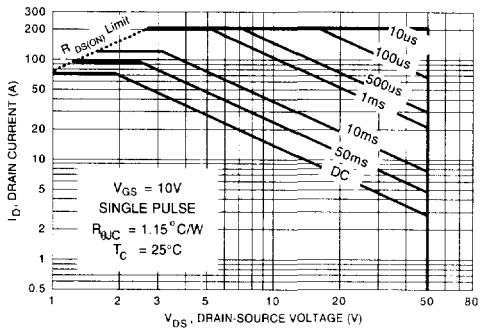


Figure 14. Maximum Safe Operating Area.

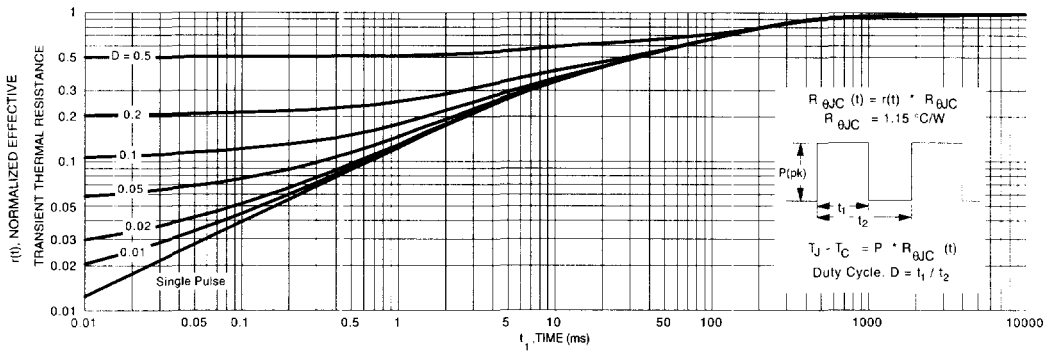


Figure 15. Transient Thermal Response Curve.